

Insulated Gate Bipolar Transistor (Ultrafast Speed IGBT), 100 A



PRODUCT SUMMARY				
V _{CES}	600 V			
V _{CE(on)} (typical)	1.92 V			
V_{GE}	15 V			
I _C	100 A			
Speed	8 kHz to 30 kHz			
Package	SOT-227			
Circuit	Single switch no diode			

FEATURES

 Ultrafast: optimized for minimum saturation voltage and speed up to 30 kHz in hard switching, > 200 kHz in resonant mode



- 26
- Very low conduction and switching losses
- Fully isolate package (2500 V_{AC/RMS})
- Very low internal inductance (≤ 5 nH typical)
- Industry standard outline
- UL approved file E78996
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- Designed and qualified for industrial level
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

BENEFITS

- Designed for increased operating efficiency in power conversion: UPS, SMPS, welding, induction heating
- Lower overall losses available at frequencies = 20 kHz
- Easy to assemble and parallel
- · Direct mounting to heatsink
- · Lower EMI, requires less snubbing
- Plug-in compatible with other SOT-227 packages

ABSOLUTE MAXIMUM RATINGS					
PARAMETER	SYMBOL	TEST CONDITIONS	MAX.	UNITS	
Collector to emitter breakdown voltage	V _{CES}		600	V	
Ocalia a calleda a call		T _C = 25 °C	200		
Continuous collector current	I _C	T _C = 100 °C	100		
Pulsed collector current	I _{CM}		400	Α	
Clamped inductive load current	I _{LM}	V_{CC} = 80 % (V_{CES}), V_{GE} = 20 V, L = 10 μH, R_g = 2.0 Ω , see fig. 13a	400		
Gate to emitter voltage	V_{GE}		± 20	V	
Reverse voltage avalanche energy	E _{ARV}	Repetitive rating; pulse width limited by maximum junction temperature	160	mJ	
RMS isolation voltage	V _{ISOL}	Any terminal to case, t = 1 min	2500	V	
Maximum power dissipation	P _D	T _C = 25 °C	500	W	
		T _C = 100 °C	200		
Operating junction and storage temperature range	T _J , T _{Stg}		-55 to +150	°C	
Mounting torque		6-32 or M3 screw	1.3 (12)	Nm (lbf.in)	

THERMAL AND MECHANICAL SPECIFICATIONS							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS	
Junction and storage temperature range	T _J , T _{Stg}		-55	-	150		
Thermal resistance, junction to case	R _{thJC}		-	-	0.25	°C/W	
Thermal resistance case to heatsink	R _{thCS}	Flat, greased, surface	-	0.05	-]	
Weight			-	30	-	g	
Mounting torque		Torque to terminal	-	-	1.1 (9.7)	Nm (lbf.in)	
Mounting torque		Torque to heatsink	-	-	1.3 (11.5)	Nm (lbf.in)	
Case style			SOT-227				



ELECTRICAL SPECIFICATIONS (T _J = 25 °C unless otherwise specified)							
PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNITS	
Collector to emitter breakdown voltage	V _{(BR)CES}	V _{GE} = 0 V, I _C = 250 μA		600	-	-	
Emitter to collector breakdown voltage	V _{(BR)ECS}	$V_{GE} = 0 \text{ V}, I_{C} = 1.0 \text{ A}$ Pulse width $\leq 80 \mu\text{s}; \text{ duty factor } \leq 0.1 \%$		18	-	-	V
Temperature coefficient of breakdown voltage	$\Delta V_{(BR)CES}/\Delta T_J$	V _{GE} = 0 V, I _C = 10 mA		-	0.38	-	V/°C
	V _{CE(on)}	I _C = 100 A	V _{GE} = 15 V See fig. 2, 5	-	1.60	1.9	V
Collector to emitter saturation voltage		I _C = 200 A		-	1.92	-	
		I _C = 100 A, T _J = 150 °C		-	1.54	-	
Gate threshold voltage	V _{GE(th)}	$V_{CE} = V_{GE}, I_{C} = 250 \mu A$		3.0	-	6.0	
Temperature coefficient of threshold voltage	$\Delta V_{GE(th)}/\Delta T_{J}$	$V_{CE} = V_{GE}$, $I_C = 2.0 \text{ mA}$		-	-11	-	mV/°C
Forward transconductance	g _{fe}	$V_{CE} = 100 \text{ V}, I_{C} = 100 \text{ A}$ Pulse width 5.0 µs, single shot		79	-	-	S
Zero gate voltage collector current		$V_{GE} = 0 \text{ V}, V_{CE} = 600 \text{ V}$		-	-	1.0	A
	I _{CES}	V _{GE} = 0 V, V _{CE} = 600 V, T _J = 150 °C		-	-	10	mA
Gate to emitter leakage current	I _{GES}	V _{GE} = ± 20 V		-	=	± 250	nA

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Total gate charge (turn-on)	Qg	I _C = 100 A	-	770	1200	
Gate-emitter charge (turn-on)	Q_ge	V _{CC} = 400 V	-	100	150	nC
Gate-collector charge (turn-on)	Q_{gc}	V _{GE} = 15 V; See fig. 8	-	260	380	
Turn-on delay time	t _{d(on)}		-	54	-	ns
Rise time	t _r	$T_J = 25 ^{\circ}\text{C}$ $I_C = 100 \text{A}$	-	79	-	
Turn-off delay time	t _{d(off)}	V _{CC} = 480 V	-	130	200	
Fall time	t _f	V _{GE} = 15 V	-	300	450	
Turn-on switching loss	E _{on}	R_g = 2.0 Ω Energy losses include "tail" See fig. 9, 10, 14	-	0.98	-	mJ
Turn-off switching loss	E _{off}		-	3.48	-	
Total switching loss	E _{ts}		-	4.46	7.6	
Turn-on delay time	t _{d(on)}	$T_J = 150~^{\circ}\text{C}$ $I_C = 100~\text{A},~V_{CC} = 480~\text{V}$ $V_{GE} = 15~\text{V},~R_g = 2.0~\Omega$ Energy losses include "tail" See fig. 10, 11, 14	-	56	-	
Rise time	t _r		-	75	-	
Turn-off delay time	t _{d(off)}		-	160	-	ns
Fall time	t _f		-	460	-	
Total switching loss	E _{ts}		-	7.24	-	mJ
Internal emitter inductance	L _E	Measured 5 mm from package	-	5.0	-	nΗ
Input capacitance	C _{ies}	V _{GE} = 0 V V _{CC} = 30 V	-	16 500	-	
Output capacitance	Coes		-	1000	-	pF
Reverse transfer capacitance	C _{res}	f = 1.0 MHz; See fig. 7	-	200	-	

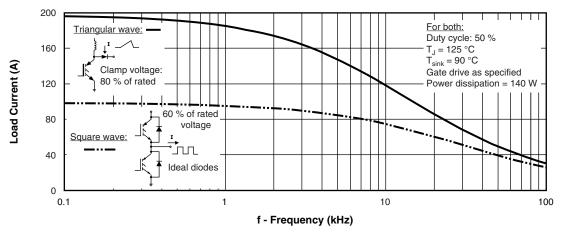


Fig. 1 - Typical Load Current vs. Frequency (Load Current = I_{RMS} of Fundamental)

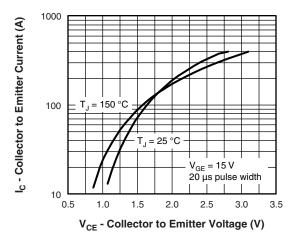


Fig. 2 - Typical Output Characteristics

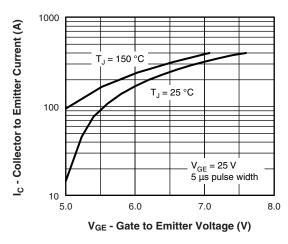


Fig. 3 - Typical Transfer Characteristics

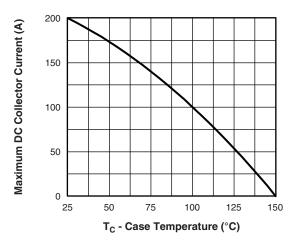


Fig. 4 - Maximum Collector Current vs. Case Temperature

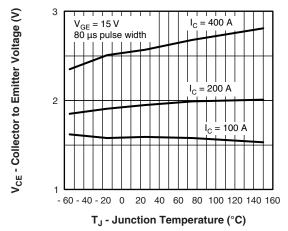


Fig. 5 - Typical Collector to Emitter Voltage vs. Junction Temperature



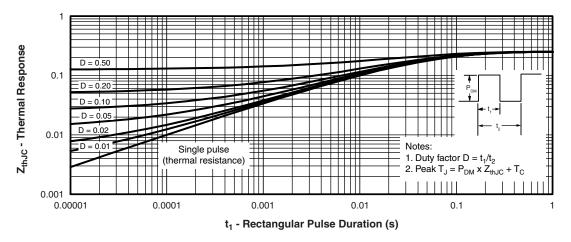


Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction to Case

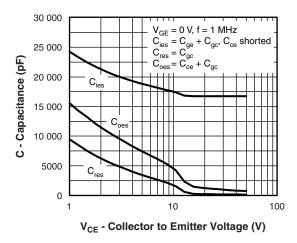


Fig. 7 - Typical Capacitance vs. Collector to Emitter Voltage

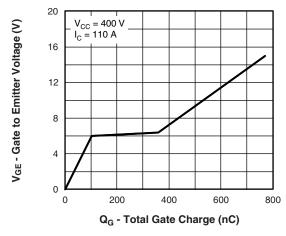


Fig. 8 - Typical Gate Charge vs. Gate to Emitter Voltage

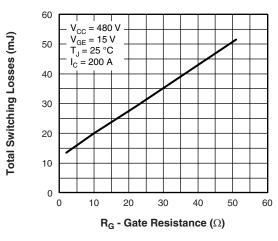


Fig. 9 - Typical Switching Losses vs. Gate Resistance

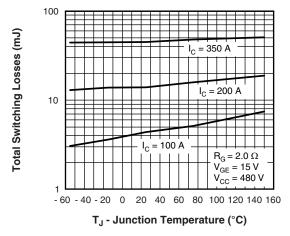


Fig. 10 - Typical Switching Losses vs. Junction Temperature



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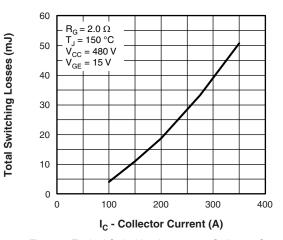


Fig. 11 - Typical Switching Losses vs. Collector Current

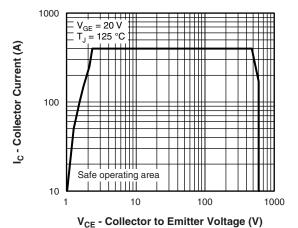
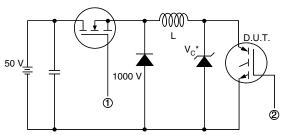


Fig. 12 - Turn-Off SOA



* Driver same type as D.U.T.; V_C = 80 % of V_{CE} (max)

Note: Due to the 50 V power supply, pulse width and inductor will increase to obtain rated $\rm I_d$

Fig. 13a - Clamped Inductive Load Test Circuit

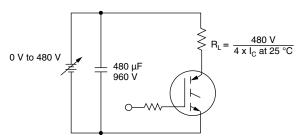


Fig. 13b - Pulsed Collector Current Test Circuit

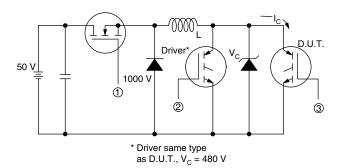


Fig. 14a - Switching Loss Test Circuit

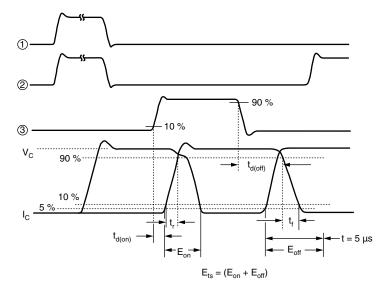
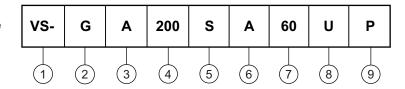


Fig. 14b - Switching Loss Waveforms

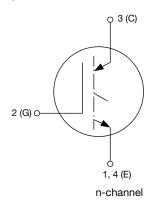
ORDERING INFORMATION TABLE

Device code

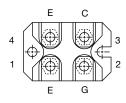


- 1 Vishay Semiconductors product
- Insulated Gate Bipolar Transistor (IGBT)
- Generation 4, IGBT silicon, DBC construction
- Current rating (200 = 200 A)
- 5 Single switch, no diode
- 6 SOT-227
- 7 Voltage rating (60 = 600 V)
- Speed/type (U = ultrafast)
- 9 • None = standard production
 - P = lead (Pb)-free

CIRCUIT CONFIGURATION





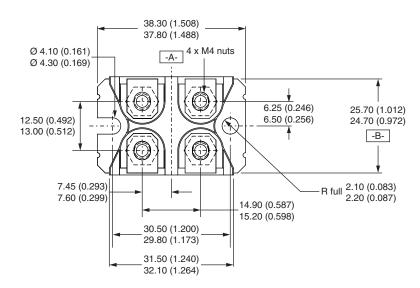


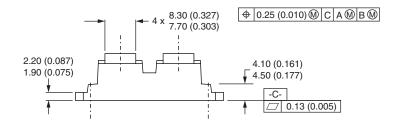
LINKS TO RELATED DOCUMENTS				
Dimensions	www.vishay.com/doc?95425			
Packaging information	www.vishay.com/doc?95423			

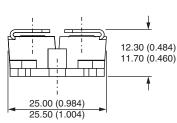


SOT-227 Generation II

DIMENSIONS in millimeters (inches)







Note

• Controlling dimension: millimeter



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